





This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

#### **Applications**

- · Switching power supplies
- DC to DC inverters
- CMOS and TTL to high current interface
- Line drivers
- Logic buffers
- Pulse amplifiers

#### Features

- · High speed, high current switching
- Current sharing capability when paralleled
- Directly interface to CMOS, DTL, TTL logic
- Simple DC biasing
- Extended safe operating area
- Inherently temperature stable



### maximum ratings (T<sub>A</sub> = 25°C) (unless otherwise specified)

RATING	SYMBOL	VN30ABA/ VN35ABA	VN67ABA	VN89ABA	VN90ABA	UNITS
Drain-Source Voltage	V <sub>DSS</sub>	35	60	80	90	Volts
Drain-Gate Voltage, $R_{GS}$ = 1M $\Omega$	VDGR	35	60	80	90	Volts
Continuous Drain Current @ T <sub>A</sub> = 25°C	۱ <sub>D</sub>	1.2	1.2	1.2	1.2	А
Peak Drain Current <sup>(1)</sup>	IDM	3.0	3.0	3.0	3.0	A
Gate-Source Voltage	V <sub>GS</sub>	±30	±30	±30	±30	Volts
Total Power Dissipation @ T <sub>A</sub> = 25°C Derate Above 25°C	PD	6.25 50	6.25 50	6.25 50	6.25 50	Watts mW/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	-55 to 150	-55 to 150	-55 to 150	°C

### thermal characteristics

Thermal Resistance, Junction to Ambient	R <sub>∂JA</sub>	20	20	20	20	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/16" from Case for 10 Seconds	ΤL	300	300	300	300	°C

(1) Repetitive Rating: Pulse width limited by max. junction temperature.

# electrical characteristics ( $T_A = 25^{\circ}C$ ) (unless otherwise specified)

CHARACTERIS	TIC	SYMBOL	MIN	ТҮР	MAX	UNIT
off characteristics						
Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0V, I <sub>D</sub> = 10 μA)	VN30ABA;VN35ABA VN67ABA VN89ABA VN90ABA	BVDSS	35 60 80 90	 		Volts
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 25, V <sub>GS</sub> = 0V)		IDSS	_	_	10	μA
Gate-Source Leakage Current (V <sub>GS</sub> = 15V, V <sub>DS</sub> = 0V)		IGSS	_		100	nA

## on characteristics\*

Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 1 mA)		V <sub>GS(TH)</sub>	0.8	1.2	-	Volts
Static Drain Source On-State Resistance (V <sub>GS</sub> = 5V) (I <sub>D</sub> = 0.3A)	VN30ABA VN35ABA VN67ABA VN89ABA VN90ABA	R <sub>DS(ON)</sub>			6.0 4.5 5.1 5.1 6.0	Ohms
Static Drain-Source On-State Resistance (V <sub>GS</sub> = 10V, I <sub>D</sub> = 1.0A)	VN30ABA VN35ABA VN67ABA VN89ABA VN90ABA	R <sub>DS(ON)</sub>			5.0 2.5 3.5 4.5 5.0	Ohms
On-State Drain Current (V <sub>DS</sub> = 25V, V <sub>GS</sub> = 10V)		ID(ON)	1	_		Amp
Forward Transconductance (V <sub>DS</sub> = 25V, I <sub>D</sub> = 0.5A)		9fs	_	.25		mhos

## dynamic characteristics

Input Capacitance	V <sub>GS</sub> = 0V	C <sub>iss</sub>	_		50	pF
Output Capacitance	V <sub>DS</sub> = 24V	C <sub>oss</sub>	—		40	pF
Reverse Transfer Capacitance	f = 1 MHz	C <sub>rss</sub>	—	—	10	pF

# switching characteristics\*

Turn-on Delay Time	See switching times	t <sub>d(on)</sub>	<u> </u>	—	10	ns
Turn-off Delay Time	waveforms below	t <sub>d(off)</sub>	—	—	10	ns

\*Pulse Test: Pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%



### SWITCHING TIME TEST WAVEFORMS